



Power MOSFETS

DATASHEET

LM40018NAM8A

N-Channel
Enhancement Mode MOSFET



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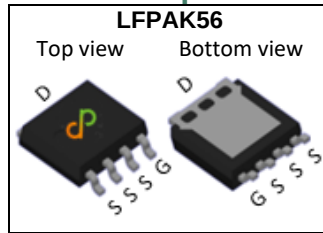


Quality Management Systems

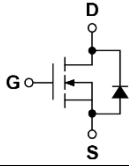
ISO 9001:2015 Certificate

N-Channel Enhancement Mode MOSFET

Pin Description



Symbol



Product Summary

Symbol	N-Channel	Unit
V_{DS}	45	V
$R_{DS(ON)-Max}$	2.0	m Ω
ID	132	A

Feature

- Fast switching speed
- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS and Rg Tested
- Moisture Sensitivity Level MSL1

Applications

- DC-to-DC converters
- Switch Mode Power Supply
- Brushless DC motor control

Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM40018NAM8A	LFPAK56	Tape & Reel	4000 / Tape & Reel	40018 □□□□□□

Note : □□□□□□ = Lot Code

Absolute Maximum Ratings (T_J=25°C Unless Otherwise Noted)

Symbol	Parameter	N-Channel	Unit
V_{DS}	Drain-Source Voltage	45	V
V_{GS}	Gate-Source Voltage	±20	V
T_J	Maximum Junction Temperature	175	°C
T_{STG}	Storage Temperature Range	-55 to 175	°C
I_S	Diode Continuous Forward Current	$T_C=25^\circ\text{C}$ 41	A
I_{SP}	Diode Pulse Current	$T_C=25^\circ\text{C}$ 400 ^①	A
I_{DM}	Pulse Drain Current Tested	$T_C=25^\circ\text{C}$ 330	A
I_D	Continuous Drain Current	$T_C=25^\circ\text{C}$ 132 $T_C=100^\circ\text{C}$ 93	A
P_D	Maximum Power Dissipation	$T_C=25^\circ\text{C}$ 63 $T_C=100^\circ\text{C}$ 31	W
I_D	Continuous Drain Current	$T_A=25^\circ\text{C}$ 29 $T_A=70^\circ\text{C}$ 24	A
P_D	Maximum Power Dissipation	$T_A=25^\circ\text{C}$ 3.0 $T_A=70^\circ\text{C}$ 2.1	W
I_{AS} ^②	Avalanche Current, Single pulse	$L=0.2\text{mH}$ 35 $L=0.5\text{mH}$ 18	A
E_{AS} ^③	Avalanche Energy, Single pulse	$L=0.2\text{mH}$ 122 $L=0.5\text{mH}$ 81	mJ

Thermal Characteristics

Symbol	Parameter	Rating	Unit
$R_{\theta JC}$	Thermal Resistance-Junction to Case	Steady State 2.4	°C/W
$R_{\theta JA}$ ^③	Thermal Resistance-Junction to Ambient	Steady State 50	°C/W

Note ① : Max. current is limited by bonding

Note ② : UIS tested and pulse width are limited by maximum junction temperature 175°C

Note ③ : Surface Mounted on 1in² FR-4 board with 1oz

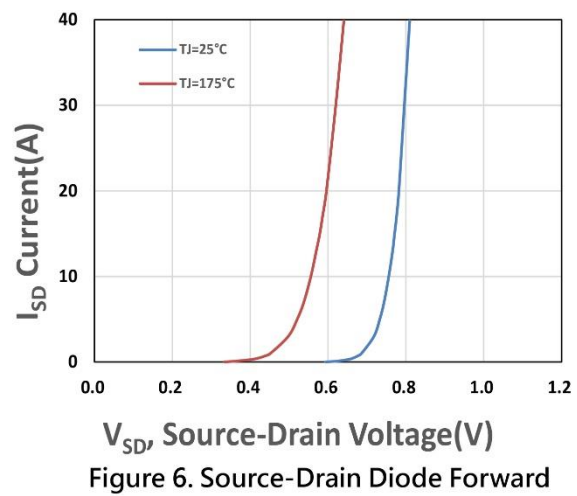
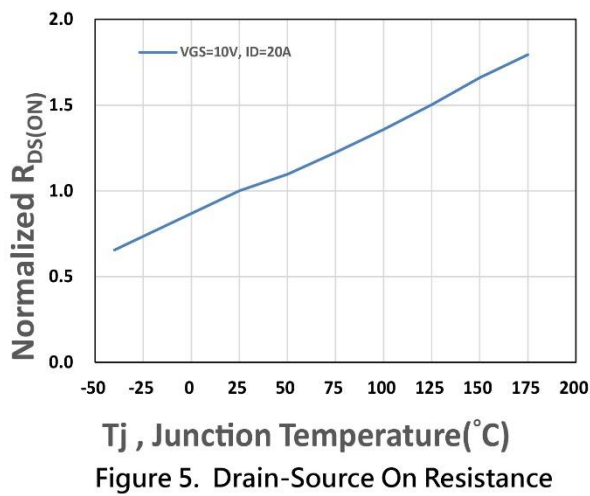
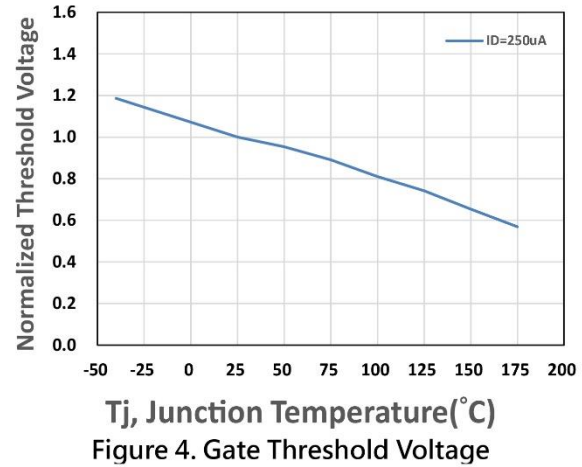
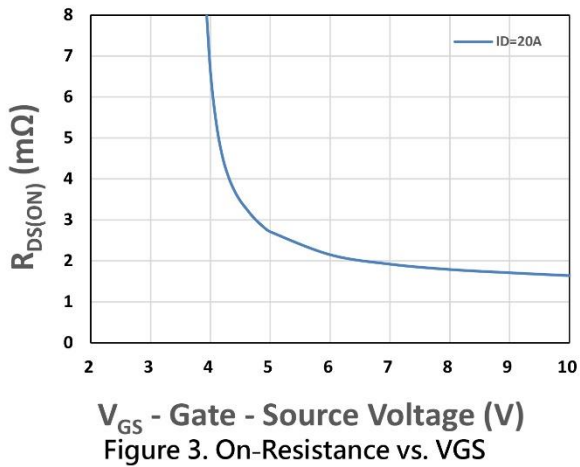
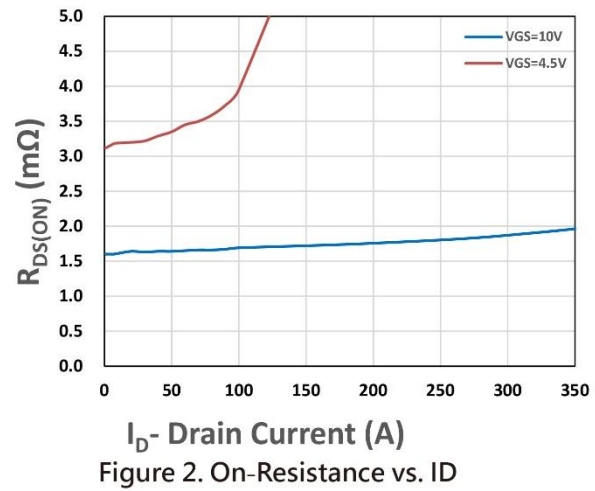
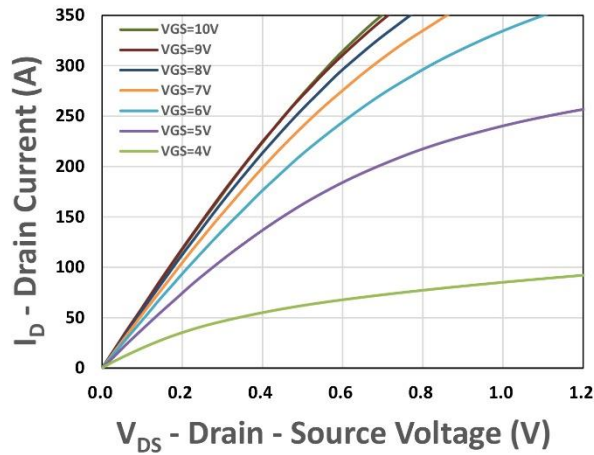
N-Channel Electrical Characteristics (T_J=25°C Unless Otherwise Noted)

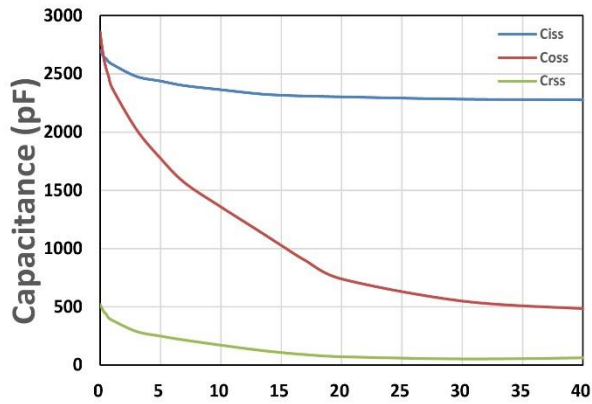
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250uA	45	-	-	V
BV _{DSS}	Drain-Source Breakdown Voltage (transient)	V _{GS} =0V, I _{DS} (aval)=35 A, time < 100 us	48	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =32V, V _{GS} =0V	-	-	1	uA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250uA	1.3	1.7	2.3	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ^④	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =20A	-	1.65	2.0	mΩ
		V _{GS} =4.5V, I _{DS} =15A	-	3.4	4.4	
gfs	Forward Transconductance	V _{DS} =5V, I _{DS} =10A	-	40	-	S
Dynamic Characteristics ^⑤						
R _G	Gate Resistance	V _{GS} =0V,V _{DS} =0V, Freq.=1MHz	-	1.3	-	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =20V, Freq.=1MHz	-	2303	-	pF
C _{oss}	Output Capacitance		-	741	-	
C _{rss}	Reverse Transfer Capacitance		-	73	-	
t _{d(ON)}	Turn-on Delay Time	V _{GS} =10V,V _{DS} =20V, I _D =1A,R _{GEN} =1Ω	-	12	-	nS
t _r	Turn-on Rise Time		-	10	-	
t _{d(OFF)}	Turn-off Delay Time		-	29	-	
t _f	Turn-off Fall Time		-	49	-	
Q _g	Total Gate Charge	V _{GS} =4.5V,V _{DS} =20V, I _D =20A		16		nC
Q _g	Total Gate Charge	V _{GS} =10V,V _{DS} =20V, I _D =20A	-	33	-	nC
Q _{gs}	Gate-Source Charge		-	8	-	
Q _{gd}	Gate-Drain Charge		-	5	-	
Source-Drain Characteristics						
V _{SD} ^④	Diode Forward Voltage	I _{SD} =25A, V _{GS} =0V	-	0.75	1.1	V
t _{rr}	Reverse Recovery Time	I _F =10A, V _R =20V	-	36	-	nS
Q _{rr}	Reverse Recovery Charge	dI _F /dt=100A/μs	-	27	-	nC

Note ④ : Pulse test (pulse width≤300us, duty cycle≤2%).

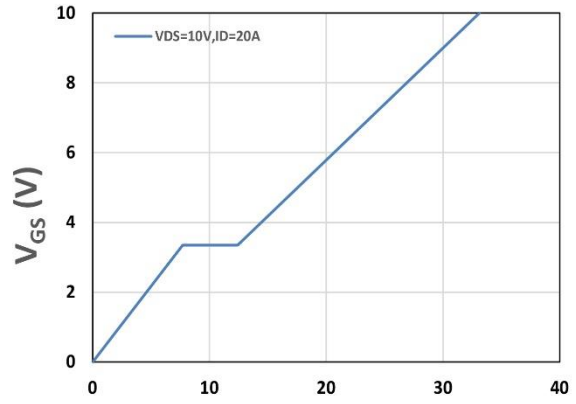
Note ⑤ : Guaranteed by design, not subject to production testing.

N-Channel Typical Characteristics

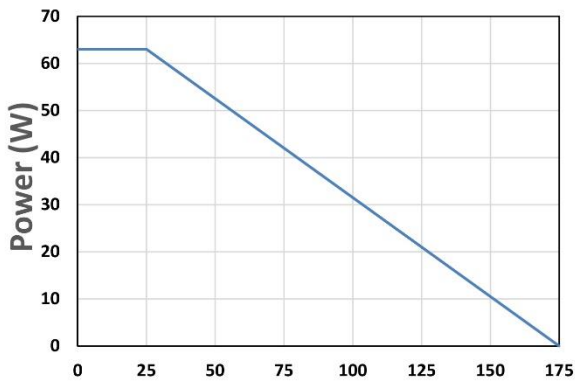




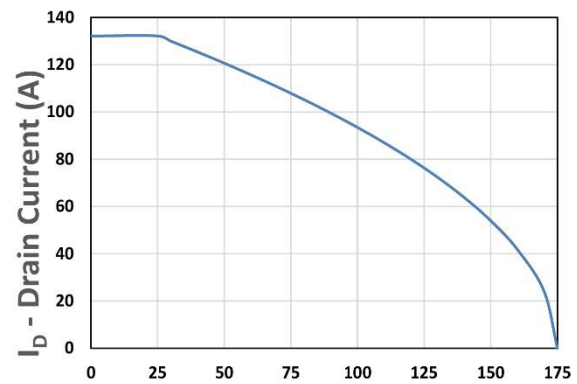
V_{DS} - Drain - Source Voltage (V)
Figure 7. Capacitance



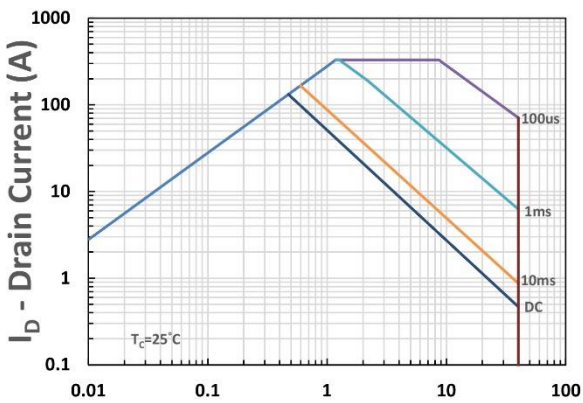
Q_g , Total Gate Charge (nC)
Figure 8. Gate Charge Characteristics



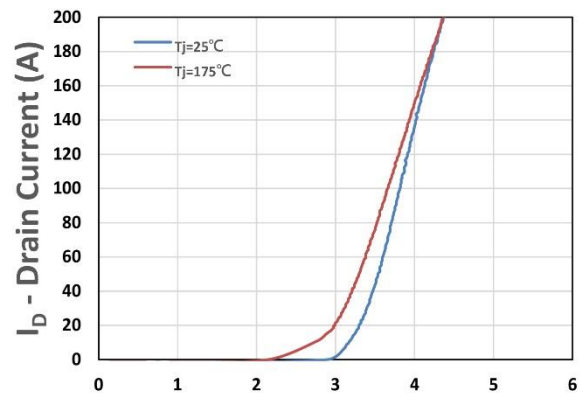
T_c -Case Temperature (°C)
Figure 9. Power Dissipation



T_c -Case Temperature (°C)
Figure 10. Drain Current



V_{DS} - Drain-Source Voltage (V)
Figure 11. Safe Operating Area



V_{GS} - Gate - Source Voltage (V)
Figure 12. Transfer Characteristics

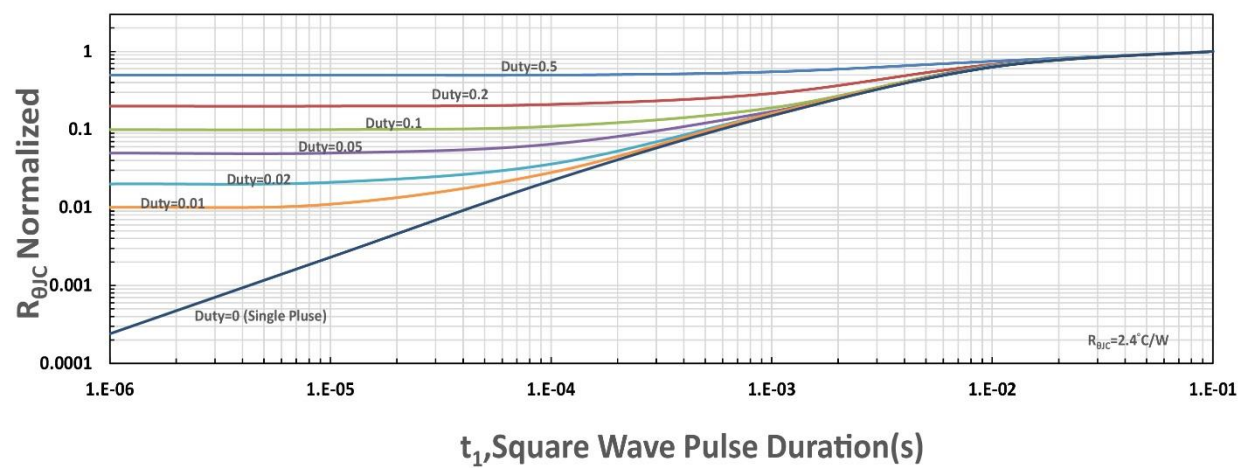


Figure 13. $R_{\theta JC}$ Transient Thermal Impedance